


<b>Search Notes</b>  	<b>Application/Control No.</b>  10560538	<b>Applicant(s)/Patent Under Reexamination</b>  IWANO ET AL.
	<b>Examiner</b>  Angel R Estrada	<b>Art Unit</b>  2831

SEARCHED			
Class	Subclass	Date	Examiner
174	50, 53, 57, 58, 17R, 521, 535, 559, 560	7/21/08	AE
439	535, 76.1, 76.2	7/21/08	AE
361	600, 601, 679	7/21/08	AE
220	3..2-3.9, 4.02, 427.	7/21/08	AE
385	134, 135	7/21/08	AE

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner